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ISSUE CLASSIFICATION	
Class	Subclass

PATENT NUMBER

U.S. **UTILITY** Patent Application

 O.I.P.E. SCANNED <u>HKm4</u> O.A. <u>2024</u>	PATENT DATE
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APPLICATION NO. 09/964211	CONT/PRIOR D F	CLASS 324	SUBCLASS	ART UNIT 2858	EXAMINER
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APPLICANTS

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TITLE

Semiconductor device testing apparatus and a test tray for use in the testing apparatus

PTO-2040
12/89

[illegible]

<input type="checkbox"/> TERMINAL DISCLAIMER	DRAWINGS		CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims
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